Cell, Volume 182

## **Supplemental Information**

## **3D Correlative Cryo-Structured Illumination**

#### Fluorescence and Soft X-ray Microscopy

## **Elucidates Reovirus Intracellular Release Pathway**

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Wavelength Ex/Em (nm)	Theoretical WF XY resolution	Measured WF XY resolution	Theoretical SIM XY resolution	Measured SIM XY resolution	Theoretical Z resolution	Measured WF Z resolution	Measured SIM Z resolution
405/452	310	360	160	240	680	790	540
488/525	360	420	190	200	790	930	520
561/605	410	440	210	220	910	1000	590
647/680	460	580	240	320	1020	1510	850

Supplemental Table 1. Optical resolution values for representative structured illumination data at beamline B24. Related to Figure 1.

Resolution parameters for the cryoSIM in nm for the lateral (XY) and axial (Z) directions at the 4 wavelengths available giving theoretical resolutions for widefield images and measured FWHM values from fitted Gaussians for widefield and SIM images in the lateral and axial directions. Theoretical resolutions are derived from the Rayleigh Criterion,  $d= 1.22 \lambda/2NA$  for the lateral measures and  $d= 1.22 \lambda/NA^2$  for axial, where  $\lambda$  is the emission wavelength and the objective NA is 0.9. Theoretical SIM resolutions were calculated from 1/d = (1/r) + (1/s), where d is the achievable resolution, r is the widefield resolution at that wavelength and s is the illumination stripe width used for that wavelength.

# Supplementary Table2. Optical performance values for the transmission X-ray microscope water-window imaging. Related to Figure 2.

Higher resolution $dr_N = 25 \text{ nm}$					
Condenser NA <sub>2.4nm</sub> =0.031 (31 mrad) ; Objective NA <sub>2.4nm</sub> =0.0477 (47.7 mrad) TXM optical system presents as partially coherent (NA condenser/NA objective <1)					
Raw Data					
Magnification=1300 FOV=10 nm Pixel size=10 nm					
DOF=1μm Depth/Axial resolution=0.5 μm					
<b>Lateral resolution</b> Theoretical/Expected Rayleigh = 30.5 nm Theoretical/Expected (partial coherence) = <15nm (leveraged against loss of contrast)					
Measured (Siemens star) = 120 nm (signal: noise=5:1; Rose criterion compliant) 60 nm (signal: noise=4:1; 3σ compliant) 30 nm (signal:noise=2:1)					
ReconstructionExpected lateral@ 0.5 $\mu$ m:<40 nm (up to $\theta$ +/-65°)@ 5.0 $\mu$ m:<40 nm (up to $\theta$ +/-2.8°)					
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Lower resolution dr <sub>N</sub> = 40nm					
Condenser NA <sub>2.4nm</sub> =0.031 (31 mrad) ; Objective NA <sub>2.4nm</sub> =0.0298 (29.8 mrad) Optical system presents as almost fully incoherent (NA condenser/NA objective ≈ 1)					
Raw data					
Magnification=812.5 FOV=16 nm Pixel size=16 nm					
DOF=2.6 μm Depth/Axial resolution=1.3 μm					
<b>Lateral resolution</b> Theoretical/Expected (no coherence) = 48.8 nm Theoretical/Expected (partial coherence) = up to 24 nm (leveraged against loss of contrast)					
Measured (Siemens star) = 120 nm (signal: noise=5:1; Rose criterion compliant) 60 nm (signal: noise=3:1; 3σ compliant) 30 nm (signal: noise=1.2:1)					
Reconstruction					

Expected <sub>tilt series</sub> =	<ul> <li>@ 0.5 μm: &lt;60 nm (up to θ +/-70°)</li> <li>@ 5.0 μm: &lt;60 nm up to θ +/18°)</li> </ul>
FSCraw data (tilt series)	3σ = 127 nm ½ bit = 145 nm
FSCreconstructed data	3σ = 155 nm ½ bit = 183 nm

Theoretical resolutions for incoherent illumination are derived from the Rayleigh Criterion, d= 1.22  $\lambda$ /2NA for the lateral measures and d= 1.22  $\lambda$ /NA<sup>2</sup> for axial, where  $\lambda$  is 2.5 nm (500 eV). Magnification was calculated as m=physical pixel size/ recorded pixel size. All values of theoretical resolutions for partially-coherent imaging are estimated based on doubling of resolution as the optical transfer function approaches zero on the caveat that useful contrast will have been lost before such value is reached. All measured values have been assessed with  $\lambda$ =2.5 nm (working illumination wavelength at beamline B24 is 2.5 nm or 500 eV). Fourier Shell Correlation estimates were generated from representative X-ray data (U2OS cells) using the EBI Fourier Shell Correlation server at:

https://www.ebi.ac.uk/pdbe/emdb/validation/fsc/ (van Heel and Schatz, 2005).